

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10558094	YOON ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	BENJAMIN OSTERHOUT	1792

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
134	56D, 105, 184, 198	20090324	BO

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Performed an Inventor Search in Palm	20090324	BO
Performed an East Search (US-PGPub, USPAT, USOCR, EPO, JPO, Derwent)	20090323	BO

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/B. O./  
Examiner.Art Unit 1792